

Notice of References Cited	Application/Control No. 10/730,069	Applicant(s)/Patent Under Reexamination KANG, HEE BOK	
	Examiner VanThu Nguyen	Art Unit 2824	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0122764 A1	06-2005	Takashima, Daisaburo	365/145
*	B	US-6,944,695 B1	09-2005	Tangen, Wayne A.	710/107
*	C	US-6,304,923 B1	10-2001	Klein, Dean A.	710/41
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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